

Search Notes

Application/Control No.

10/698,717

Examiner

VAN T. PHAM

Applicant(s)/Patent under
Reexamination

NAUKA ET AL.

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner
369	126, 101.	1/25/2006 <i>updated on 12/31/07</i>	VP <i>vp</i>

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (US-PGPUB; USPAT; USOCR;EPO;JPO;DERWENT;IBM_T DB) 369/ and text search only see search history printout.	12/31/2007	VP